

$V_{CE} = 3300 \text{ V}$  $I_C = 50 \text{ A}$ **IGBT-Die****5SMX 12M3300****Die size: 13.6 x 13.6 mm**

Doc. No. 5SYA1621-02 Sep 05

- Low loss, rugged SPT technology
- Smooth switching for good EMC
- Large bondable emitter area
- Passivation: SIPOS and Silicon Nitride plus Polyimide

**Maximum rated values <sup>1)</sup>**

Parameter	Symbol	Conditions	min	max	Unit
Collector-emitter voltage	$V_{CES}$	$V_{GE} = 0 \text{ V}$		3300	V
DC collector current	$I_C$			50	A
Peak collector current	$I_{CM}$	Limited by $T_{vjmax}$		100	A
Gate-emitter voltage	$V_{GES}$		-20	20	V
IGBT short circuit SOA	$t_{psc}$	$V_{CC} = 2500 \text{ V}, V_{CEM} \leq 3300 \text{ V}$ $V_{GE} \leq 15 \text{ V}, T_{vj} \leq 125 \text{ °C}$		10	$\mu\text{s}$
Junction temperature	$T_{vj}$		-40	125	$^{\circ}\text{C}$

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<sup>1)</sup> Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747 - 9

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**IGBT characteristic values** <sup>2)</sup>

Parameter	Symbol	Conditions	min	typ	max	Unit	
Collector-emitter saturation voltage	$V_{CE\ sat}$	$I_C = 50\ A, V_{GE} = 15\ V$	$T_{vj} = 25\ ^\circ C$	2.6	3.1	3.5	V
			$T_{vj} = 125\ ^\circ C$		3.8		V
Collector cut-off current	$I_{CES}$	$V_{CE} = 3300\ V, V_{GE} = 0\ V$	$T_{vj} = 25\ ^\circ C$			100	$\mu A$
			$T_{vj} = 125\ ^\circ C$		1000		$\mu A$
Gate leakage current	$I_{GES}$	$V_{CE} = 0\ V, V_{GE} = \pm 20\ V, T_{vj} = 125\ ^\circ C$	-500		500	nA	
Gate-emitter threshold voltage	$V_{GE(TO)}$	$I_C = 10\ mA, V_{CE} = V_{GE}, T_{vj} = 25\ ^\circ C$	5.5		7.5	V	
Gate charge	$Q_{ge}$	$I_C = 50\ A, V_{CE} = 1800\ V, V_{GE} = -15 \dots 15\ V$		500		nC	
Input capacitance	$C_{ies}$	$V_{CE} = 25\ V, V_{GE} = 0\ V, f = 1\ MHz, T_{vj} = 25\ ^\circ C$		7.8		nF	
Output capacitance	$C_{oes}$			0.35			
Reverse transfer capacitance	$C_{res}$			0.09			
Internal gate resistance	$R_{Gint}$			5		$\Omega$	
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 1800\ V, I_C = 50\ A, R_G = 33\ \Omega, V_{GE} = \pm 15\ V, L_\sigma = 2400\ nH,$ inductive load	$T_{vj} = 25\ ^\circ C$	350		ns	
			$T_{vj} = 125\ ^\circ C$	330			
Rise time	$t_r$	$L_\sigma = 2400\ nH,$ inductive load	$T_{vj} = 25\ ^\circ C$	190		ns	
			$T_{vj} = 125\ ^\circ C$	200			
Turn-off delay time	$t_{d(off)}$	$V_{CC} = 1800\ V, I_C = 50\ A, R_G = 33\ \Omega, V_{GE} = \pm 15\ V, L_\sigma = 2400\ nH,$ inductive load	$T_{vj} = 25\ ^\circ C$	1140		ns	
			$T_{vj} = 125\ ^\circ C$	1250			
Fall time	$t_f$	$L_\sigma = 2400\ nH,$ inductive load	$T_{vj} = 25\ ^\circ C$	750		ns	
			$T_{vj} = 125\ ^\circ C$	770			
Turn-on switching energy	$E_{on}$	$V_{CC} = 1800\ V, I_C = 50\ A, V_{GE} = \pm 15\ V, R_G = 33\ \Omega, L_\sigma = 2400\ nH,$ inductive load, FWD: $\frac{1}{2}$ 5SLX12M3301	$T_{vj} = 25\ ^\circ C$	50		mJ	
			$T_{vj} = 125\ ^\circ C$	72			
Turn-off switching energy	$E_{off}$	$V_{CC} = 1800\ V, I_C = 50\ A, V_{GE} = \pm 15\ V, R_G = 33\ \Omega, L_\sigma = 2400\ nH,$ inductive load	$T_{vj} = 25\ ^\circ C$	67		mJ	
			$T_{vj} = 125\ ^\circ C$	84			
Short circuit current	$I_{SC}$	$t_{psc} \leq 10\ \mu s, V_{GE} = 15\ V, T_{vj} = 125\ ^\circ C, V_{CC} = 2500\ V, V_{CEM} \leq 3300\ V$		190		A	

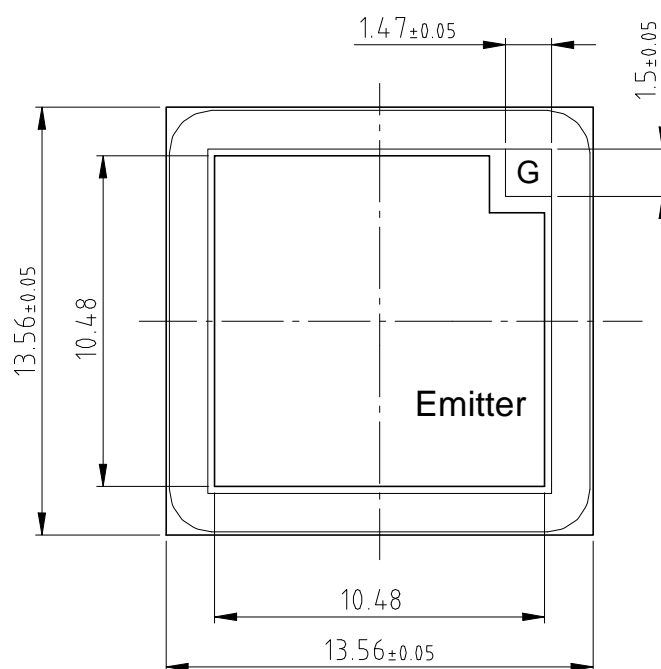
<sup>2)</sup> Characteristic values according to IEC 60747 - 9

## Mechanical properties

Parameter				Unit
Dimensions	Overall die	L x W	13.6 x 13.6	mm
	exposed front metal	L x W (except gate pad)	10.48 x 10.48	mm
	gate pad	L x W	1.5 x 1.47	mm
	thickness		385 ± 20	µm
Metallization <sup>3)</sup>	front (E)	AlSi1	4	µm
	back (C)	AlSi1 + TiNiAg	1.8 + 1.2	µm

<sup>3)</sup> For assembly instructions refer to : IGBT and Diode chips from ABB Switzerland Ltd, Semiconductors, Doc. No. 5SYA 2033.

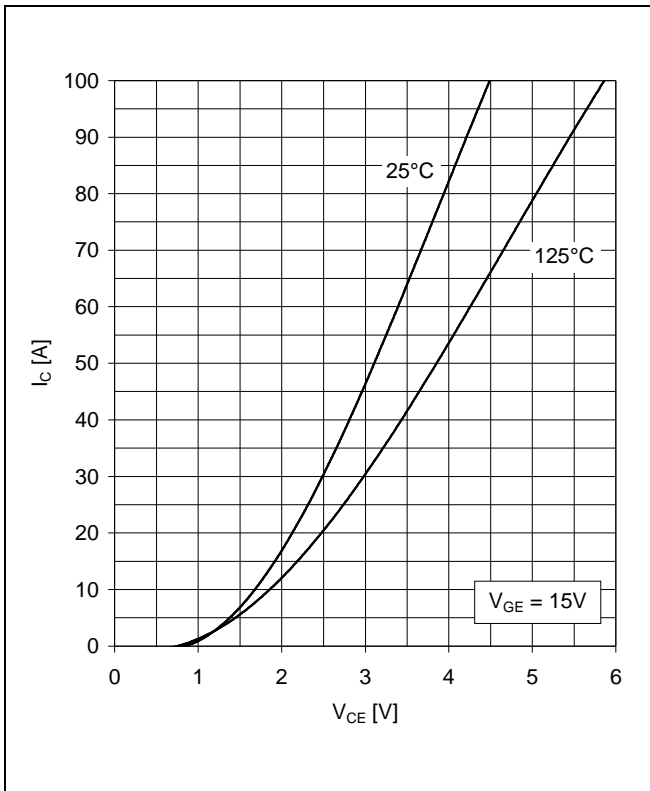
## Outline drawing



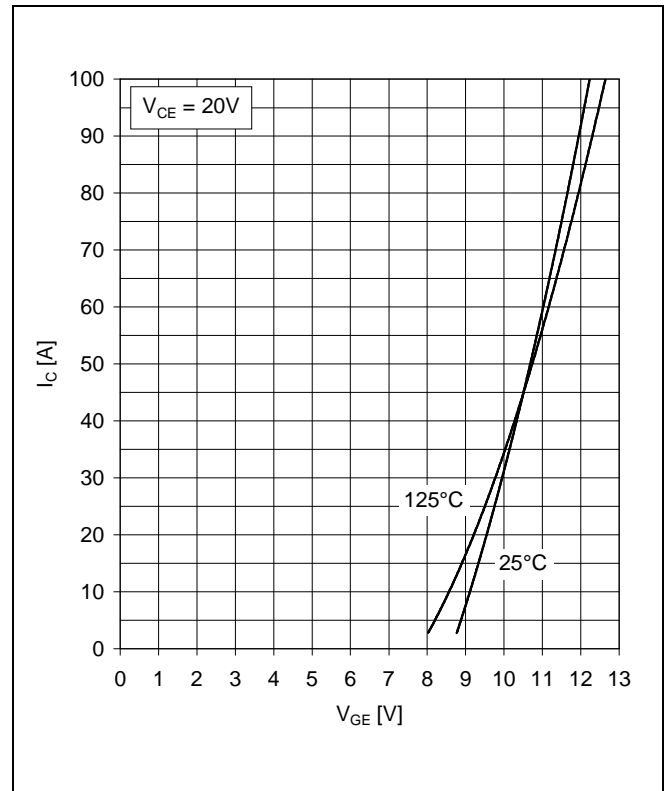
Note: all dimensions are shown in mm

This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, Chap. IX.

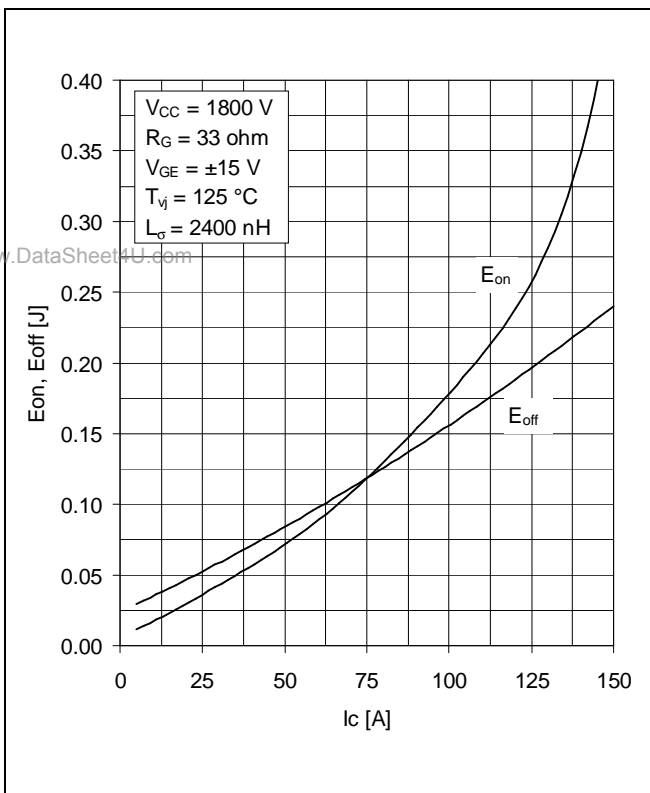
This product has been designed and qualified for Industrial Level.



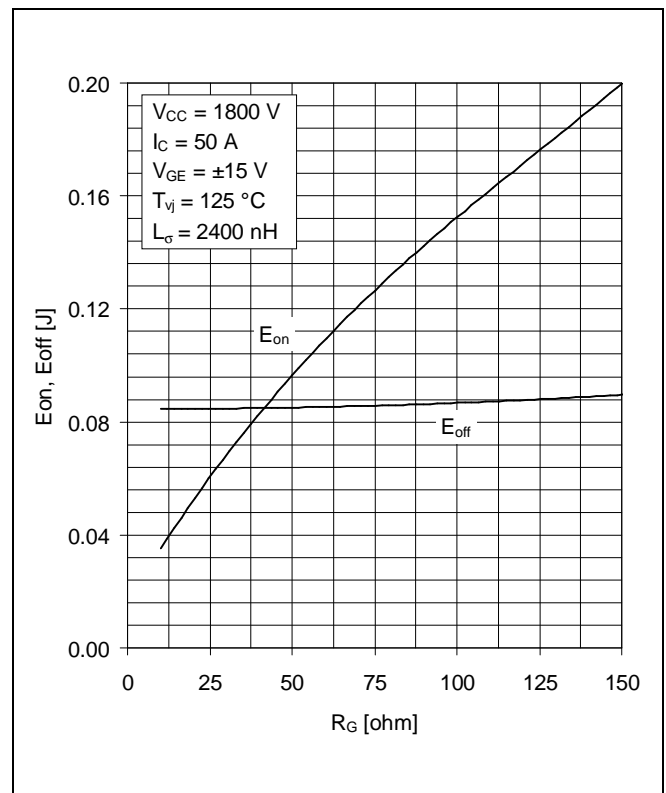
**Fig. 1** Typical on-state characteristics



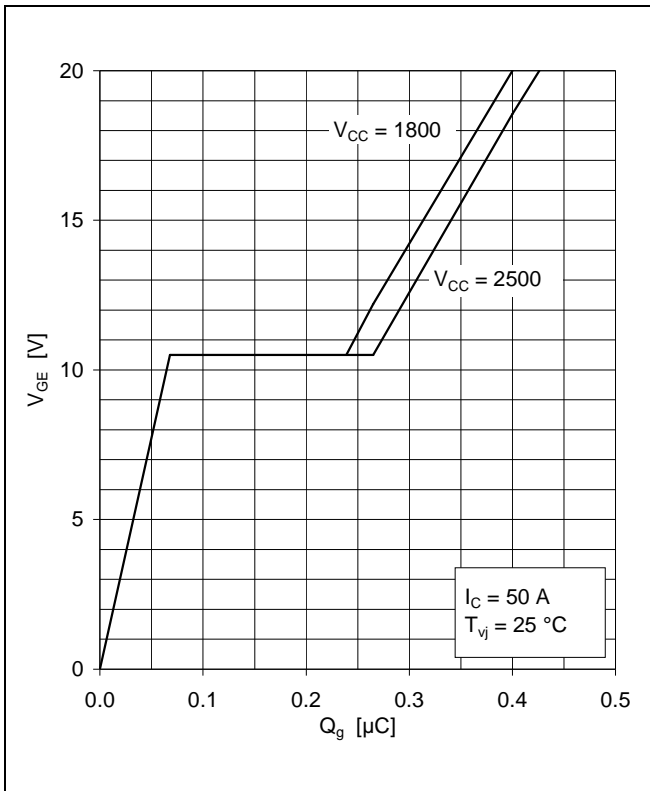
**Fig. 2** Typical transfer characteristics



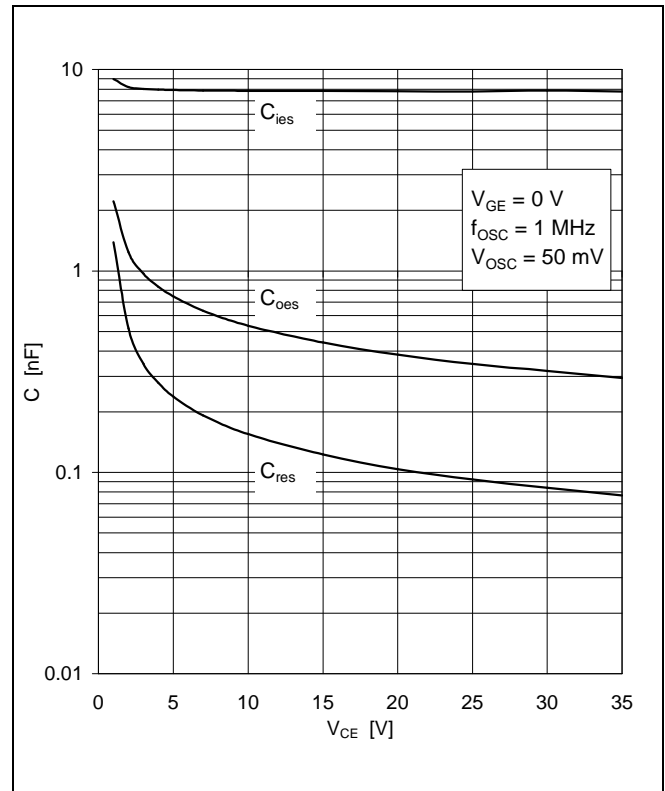
**Fig. 3** Typical switching characteristics vs collector current



**Fig. 4** Typical switching characteristics vs gate resistor



**Fig. 5** Typical gate charge characteristics



**Fig. 6** Typical capacitances vs collector-emitter voltage

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